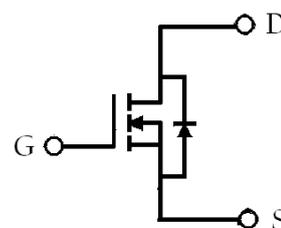
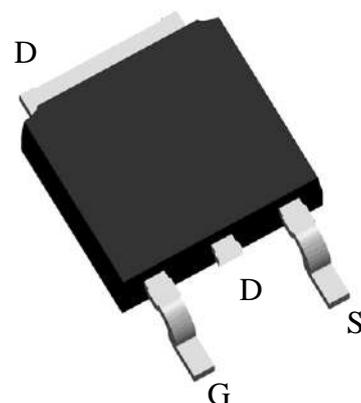


N -Channel Enhancement Mode Power MOSFET

Features:

- Low Gate Charge
- Simple Drive Requirement
- Pb-free lead plating and halogen-free package

TO-252(DPAK)



G : Gate D : Drain S : Source

BV_{DSS}	100V
I_D @ V_{GS}=10V, T_C=25°C	30A
R_{DS(ON)}@ V_{GS}=10V, I_D=20A	20.5mΩ (typ)

Ordering Information

Device	Package	Shipping
KJE020N10R	TO-252 (Pb-free lead plating and halogen-free package)	2500 pcs / Tape & Reel

Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Limits	Unit	
Drain-Source Voltage	V_{DS}	100	V	
Gate-Source Voltage	V_{GS}	± 25		
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$	I_D	30	A	
Continuous Drain Current @ $T_C=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$		21.2		
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ *2	I_{DSM}	7		
Continuous Drain Current @ $T_A=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$ *2		4.4		
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ *3		5.7		
Continuous Drain Current @ $T_A=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$ *3		3.6		
Pulsed Drain Current *1	I_{DM}	100		
Avalanche Current @ $L=0.1\text{mH}$	I_{AS}	32		
Avalanche Energy @ $L=1\text{mH}$, $I_D=15\text{A}$, $V_{DD}=25\text{V}$ *4	E_{AS}	112		mJ
Total Power Dissipation @ $T_C=25^{\circ}\text{C}$	P_D	60		W
Total Power Dissipation @ $T_C=100^{\circ}\text{C}$		30		
Total Power Dissipation @ $T_A=25^{\circ}\text{C}$ *2	P_{DSM}	2.5		
Total Power Dissipation @ $T_A=100^{\circ}\text{C}$ *2		1.0		
Total Power Dissipation @ $T_A=25^{\circ}\text{C}$ *3		1.7		
Total Power Dissipation @ $T_A=100^{\circ}\text{C}$ *3		0.7		
Operating Junction and Storage Temperature Range	T_j, T_{stg}	$-55\sim+175$	$^{\circ}\text{C}$	

Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	2.5	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max *2	$R_{th,j-a}$	50	
Thermal Resistance, Junction-to-ambient, max *3		75	

- Note :
- *1. Pulse width limited by maximum junction temperature
 - *2. When the device is mounted on 1 in² FR-4 board with 2 oz. copper.
 - *3. When the device is on the minimum pad size recommended.
 - *4. 100% tested by conditions of $L=0.1\text{mH}$, $I_{AS}=20\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=25\text{V}$.
 - *5. The power dissipation P_D is based on $T_j(\text{MAX})=175^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
 - *6. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

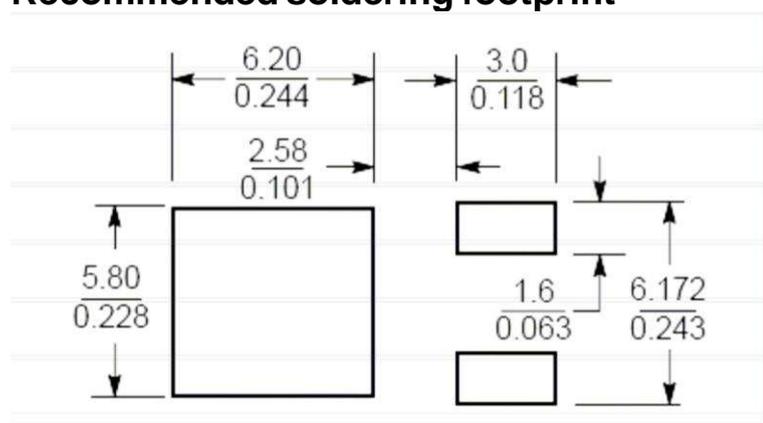
Characteristics ($T_C=25^{\circ}\text{C}$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	100	-	-	V	$V_{GS}=0\text{V}$, $I_D=250\mu\text{A}$
$\Delta BV_{DSS}/\Delta T_j$	-	0.1	-	$\text{V}/^{\circ}\text{C}$	Reference to 25°C , $I_D=250\mu\text{A}$
$V_{GS(th)}$	2	-	4	V	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$
G_{FS} *1	-	11.3	-	S	$V_{DS}=10\text{V}$, $I_D=20\text{A}$
I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 25\text{V}$, $V_{DS}=0\text{V}$

IDSS	-	-	1	μA	VDS =80V, VGS =0V
	-	-	25		VDS =80V, VGS =0V, Tj=125°C
RDS(ON) *1	-	20.5	30	mΩ	VGS =10V, ID=20A
Dynamic					
Qg *1, 2	-	15.9	-	nC	ID=20A, VDS=50V, VGS=10V
Qgs *1, 2	-	5.9	-		
Qgd *1, 2	-	4.4	-		
td(ON) *1, 2	-	14	-	ns	VDS=50V, ID=20A, VGS=10V, RG=3Ω
tr *1, 2	-	16	-		
td(OFF) *1, 2	-	20.8	-		
tf *1, 2	-	7.2	-		
Ciss	-	975	-	pF	VGS=0V, VDS=50V, f=1MHz
Coss	-	160	-		
Crss	-	21	-		
Rg	-	1.2	-	Ω	f=1MHz
Source-Drain Diode					
IS *1	-	-	30	A	
ISM *3	-	-	100		
VSD *1	-	0.74	1	V	IS=1A, VGS=0V
trr	-	27.9	-	ns	IF=20A, dIF/dt=100A/μs
Qrr	-	31.6	-	nC	

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%
 *2.Independent of operating temperature
 *3.Pulse width limited by maximum junction temperature.

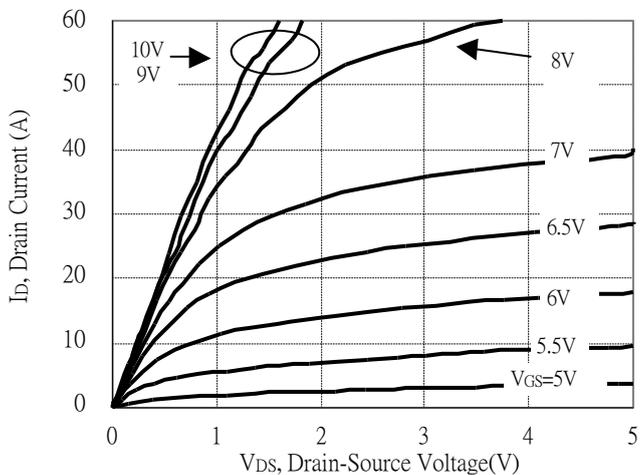
Recommended soldering footprint



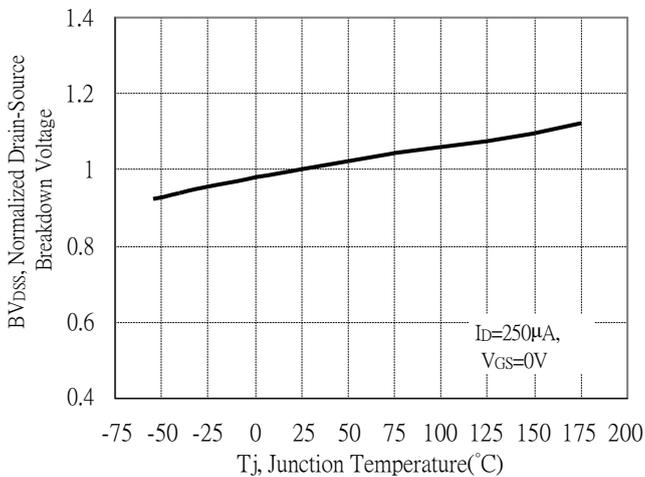
Unit ($\frac{\text{mm}}{\text{inch}}$)

Typical Characteristics

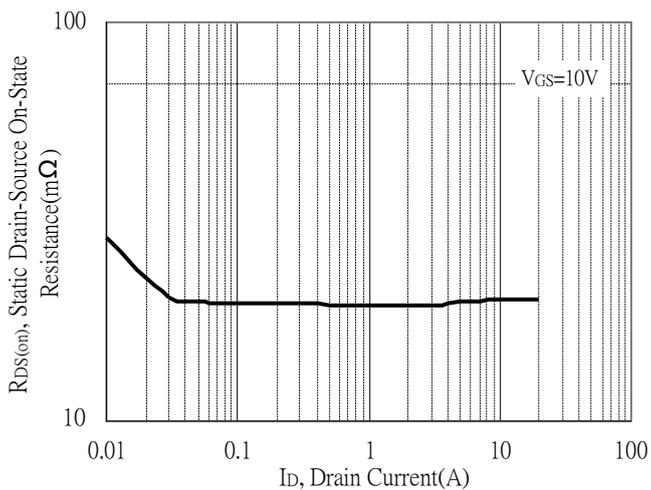
Typical Output Characteristics



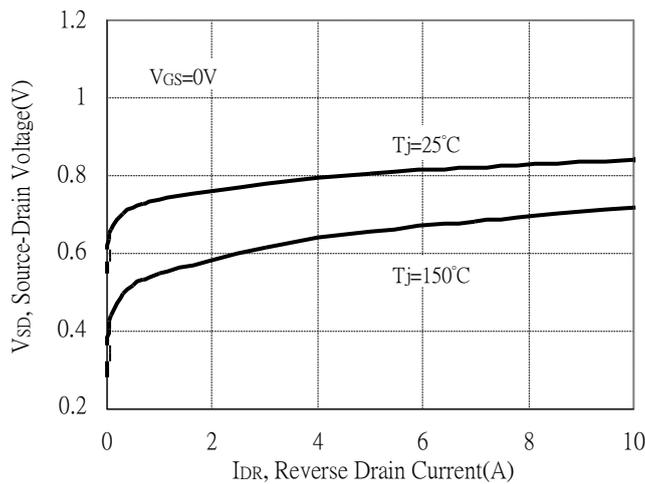
Brekdown Voltage vs Ambient Temperature



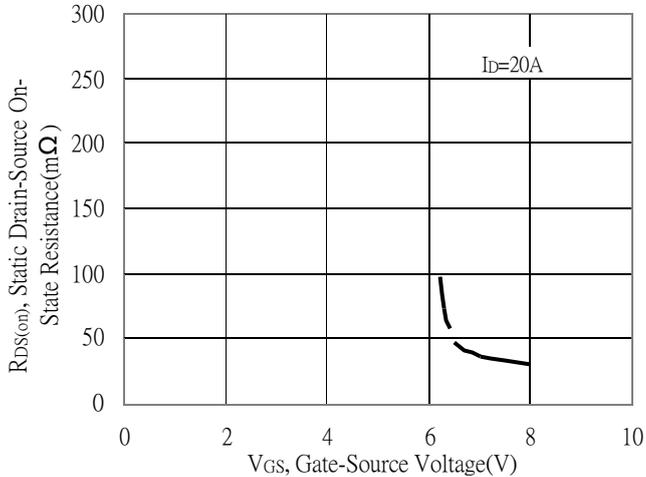
Static Drain-Source On-State resistance vs Drain Current



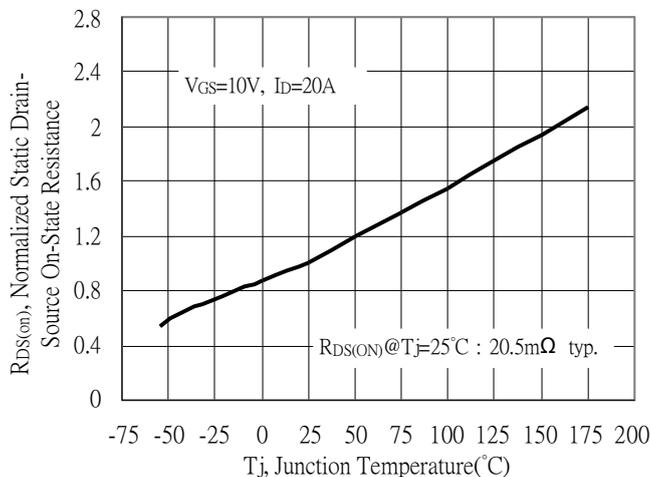
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

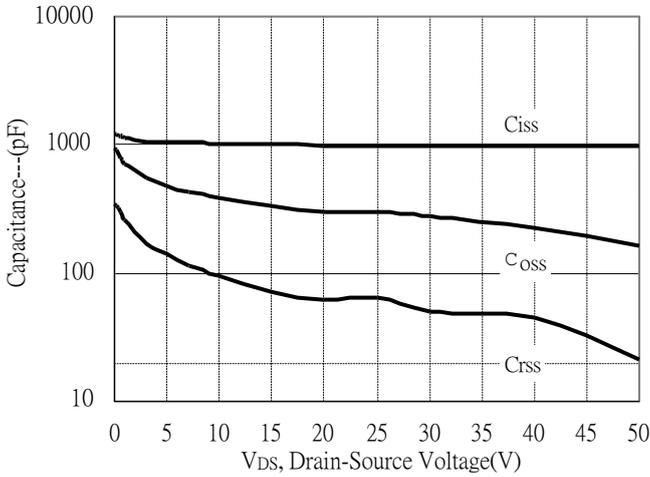


Drain-Source On-State Resistance vs Junction Temperature

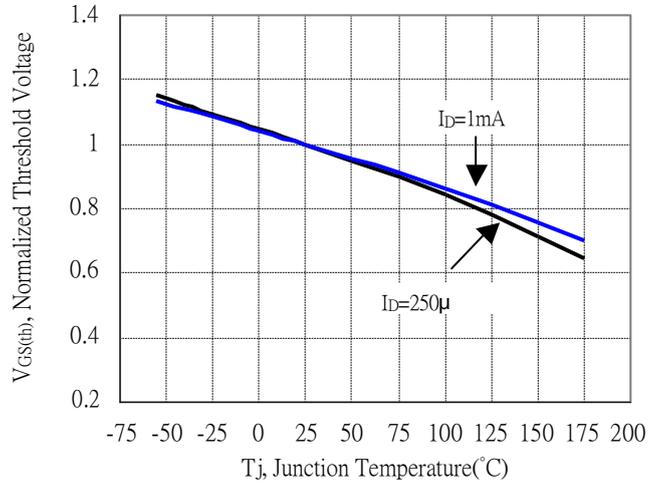


Typical Characteristics(Cont.)

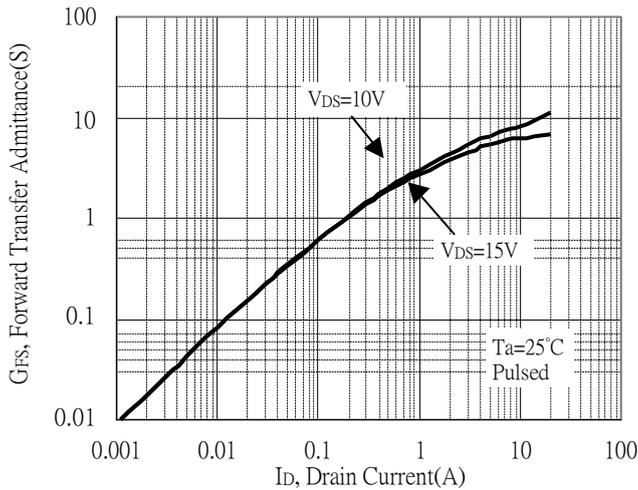
Capacitance vs Drain-to-Source Voltage



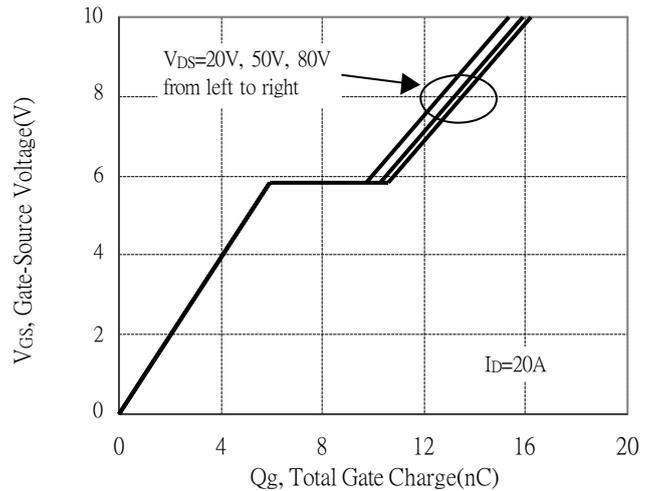
Threshold Voltage vs Junction Temperature



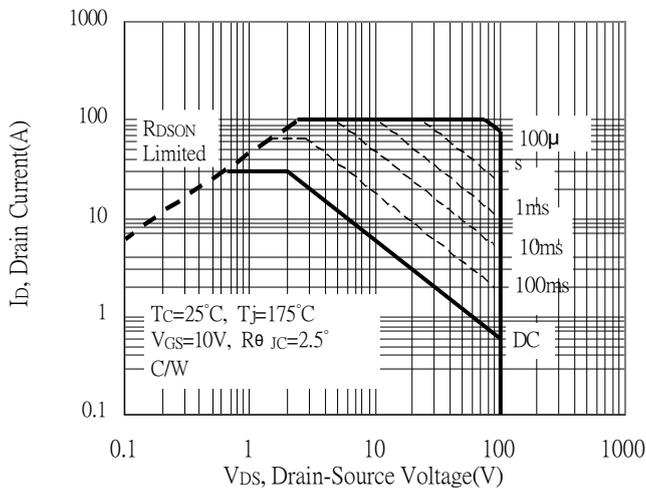
Forward Transfer Admittance vs Drain Current



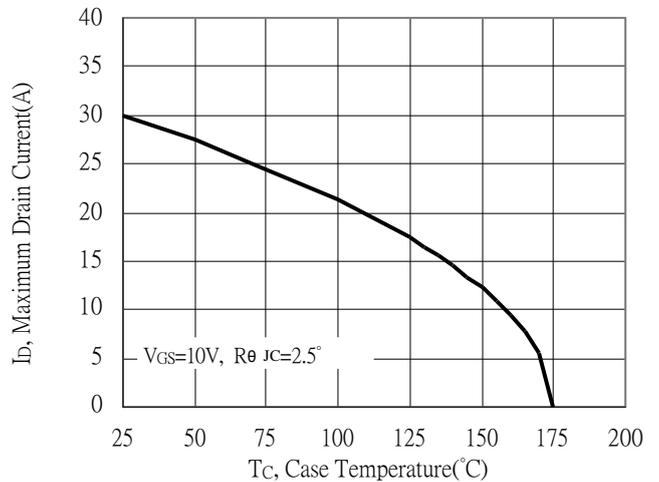
Gate Charge Characteristics



Maximum Safe Operating Area

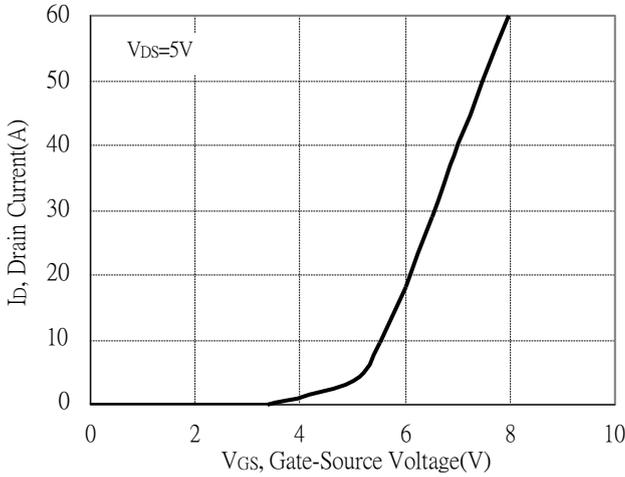


Maximum Drain Current vs Case Temperature

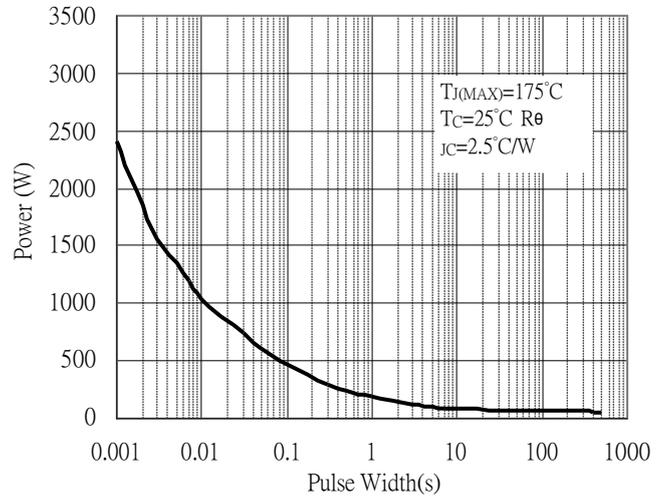


Typical Characteristics(Cont.)

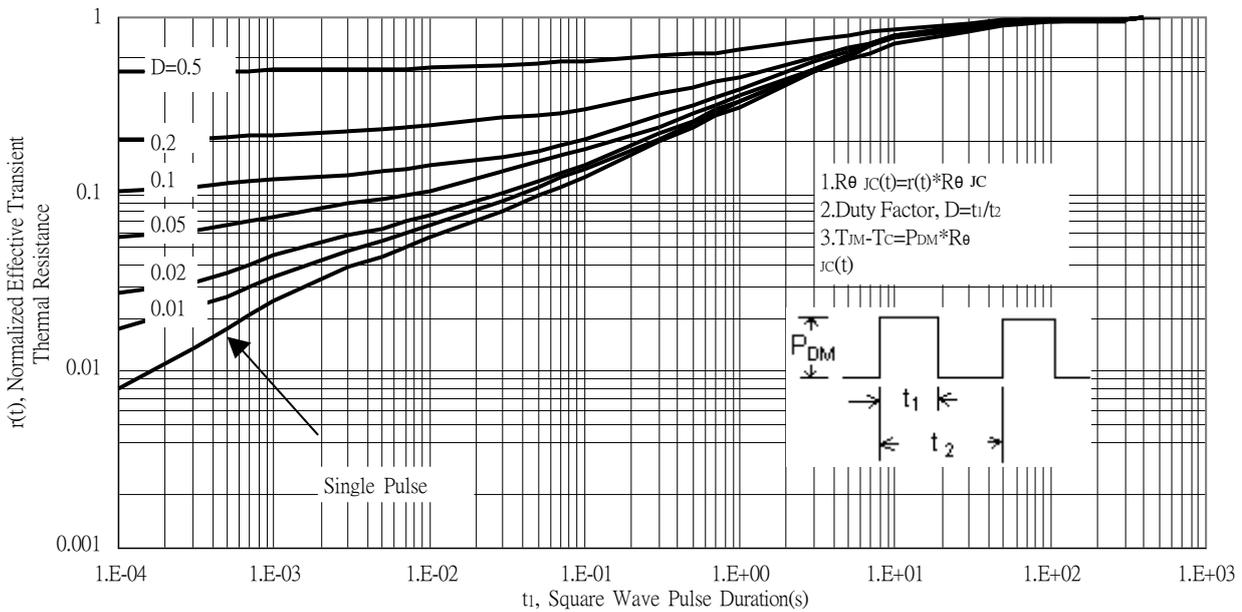
Typical Transfer Characteristics



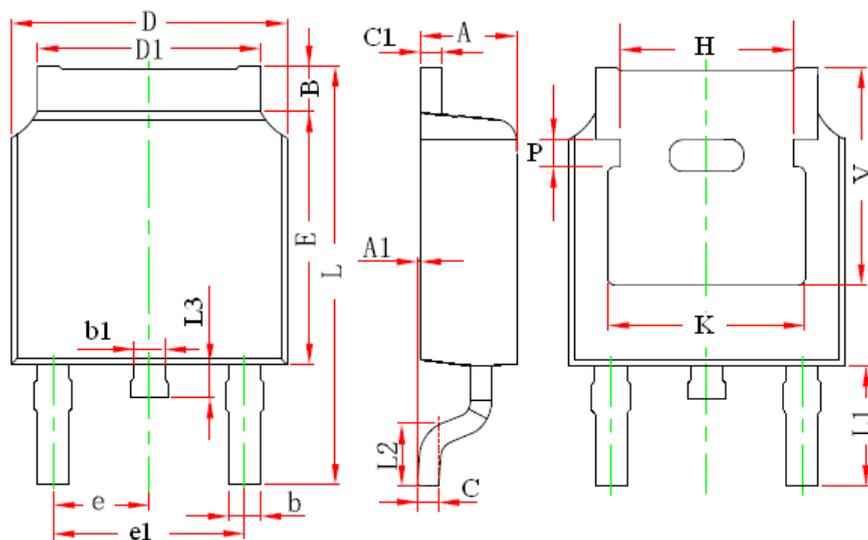
Single Pulse Power Rating, Junction to Case



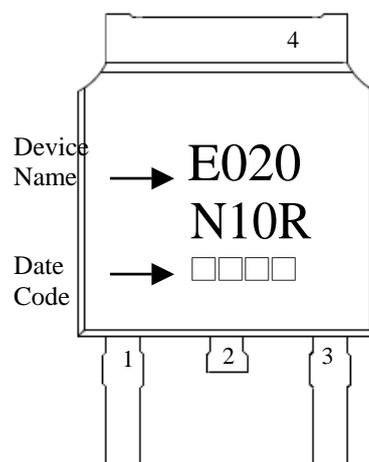
Transient Thermal Response Curves



TO-252 Dimension



Marking:



3-Lead TO-252 Plastic Surface Mount Package
 Code: J3

Style: Pin 1.Gate 2.Drain 3.Source
 4.Drain

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF